

<b>Notice of References Cited</b>	Application/Control No. 09/857,210	Applicant(s)/Patent Under Reexamination REIHS ET AL.	
	Examiner Elena Tsoy	Art Unit 1762	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,333,074	12-2001	Ogawa et al.	427/337
*	B	US-5,324,566	06-1994	Ogawa et al.	428/141
*	C	US-5,751,541	05-1998	Li et al.	361/525
*	D	US-3,867,203	02-1975	Gesing et al.	438/10
	E	US-4,331,487	05-1982	Mirra et al.	148/261
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 04168904 A	06-1992	Japan	SARUWATARI et al.	H02G 07/20
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.